

ON MINIMUM VARIANCE UNBIASED ESTIMATION OF RELIABILITY

BY Y. S. SATHE AND S. D. VARDE¹

University of Bombay

1. Introduction. The purpose of the present paper is to present a simple method of deriving the unique minimum variance unbiased estimate (MVUE) of the reliability function associated with a life distribution. The widely applicable life distributions are the normal, one- and two-parameter exponential, gamma and Weibull distributions. A good deal of work has been done on this problem. Barton [1] estimated the probability that a normal variable will take a value between two points X_1 and X_2 in its range. Pugh [7] and Laurent [6] obtained the MVUE of reliability under the one-parameter and two-parameter exponential life distributions respectively. Tate [8] considered the two-parameter exponential, gamma and Weibull distributions and obtained MVUE's of some functions of the parameters. Recently, Basu [2] put forward a method of deriving MVUE of reliability and verified these estimates. The methods used by most of these authors consist of finding conditional distribution of a component of sample-observations given the sufficient statistics. In our present method, we find a statistic which is stochastically independent of the complete sufficient statistics and whose distribution can be very easily obtained. The MVUE is based on this distribution.

2. A general theorem for finding the MVUE. Let $\mathbf{X} = (X_1, X_2, \dots, X_n)$ be a random sample of size n from a distribution function $F(x; \boldsymbol{\theta})$, where $\boldsymbol{\theta}$ denotes a vector of parameters. Let $\hat{\boldsymbol{\theta}}$ be a complete sufficient statistic for $\boldsymbol{\theta}$. Let $\psi(t, \boldsymbol{\theta})$ be a parametric function, t being a real number, and let

$$(2.1) \quad \begin{aligned} U(\mathbf{X}) &= \lambda && \text{if } Z(\mathbf{X}) \geq t, \\ &= 0 && \text{otherwise,} \end{aligned}$$

for $Z(\mathbf{X})$ a function of \mathbf{X} and λ any real number, be an unbiased estimate of $\psi(t, \boldsymbol{\theta})$. We introduce the following:

THEOREM 1. *If there exists a function $V(Z, \hat{\boldsymbol{\theta}})$ such that*

- (i) *it is stochastically independent of $\hat{\boldsymbol{\theta}}$,*
- (ii) *it is a strictly increasing function of Z for fixed $\hat{\boldsymbol{\theta}}$, and*
- (iii) *its distribution function $H(x)$ is such that*

$$\begin{aligned} H(x) &= 0 && \text{for } x < a, \\ &= 1 && \text{for } x > b. \end{aligned}$$

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a and b ($a < b$) being either finite or infinite, then the unique MVUE of $\psi(t, \theta)$ is given by

$$\begin{aligned}
 \psi^*(t, \hat{\theta}) &= \lambda && \text{if } V(t, \hat{\theta}) < a, \\
 (2.2) \quad &= \lambda \int_{V(t, \hat{\theta})}^b dH(x) && \text{if } a \leq V(t, \hat{\theta}) \leq b, \\
 &= 0 && \text{if } V(t, \hat{\theta}) > b.
 \end{aligned}$$

PROOF. Since $U(\mathbf{X})$ is an unbiased estimate of $\psi(t, \theta)$ and $\hat{\theta}$ is a complete sufficient statistic for θ , therefore, by the Rao-Blackwell-Lehmann-Scheffé theorem, the unique MVUE of $\psi(t, \theta)$ is

$$\begin{aligned}
 \psi^*(t, \hat{\theta}) &= E[U(\mathbf{X}) \mid \hat{\theta}] \\
 &= \lambda \text{Prob} [Z(\mathbf{X}) \geq t \mid \hat{\theta}] \\
 &= \lambda \text{Prob} [V(Z, \hat{\theta}) \geq V(t, \hat{\theta}) \mid \hat{\theta}] \quad \text{by (ii)} \\
 &= \lambda \text{Prob} [V(Z, \hat{\theta}) \geq V(t, \hat{\theta})] \quad \text{by (i)}.
 \end{aligned}$$

Hence by (iii) we get (2.2).

The steps in the application of this theorem are the selections of suitable functions Z and V . Function V satisfying condition (i) can be obtained by making use of the following

THEOREM 2. *If V is any statistic (not a function of the sufficient statistic $\hat{\theta}$ alone) such that its distribution does not depend upon θ , then V is stochastically independent of $\hat{\theta}$.*

The proof of this theorem is given by Hogg and Craig [5] in Section 8.9.

3. Applications. The unique MVUE's of reliability and its powers under various life distributions are obtained in this section by applying Theorem 1 of the preceding section.

Reliability at 'mission time' t is defined by

$$R(t, \theta) = \text{Prob} [X \geq t \mid \theta] = \int_t^\infty dF(x; \theta)$$

where $F(x; \theta)$ is the underlying life distribution.

The following lemma will be frequently used to find the density function of V .

LEMMA 1. *If X_1, X_2, \dots, X_n are independently and identically distributed with the density function*

$$f(x) = \theta^{-p} \Gamma^{-1}(p) e^{-x/\theta} x^{p-1}, \quad x \geq 0; p, \theta > 0,$$

then the random variable

$$\xi = X_i / (X_i + \sum_{j \neq i}^m X_j),$$

where \sum^m denotes the sum of m terms ($0 < m < n$), has the beta density function

$$(3.1) \quad f(x) = \beta^{-1}(p, mp) x^{p-1} (1-x)^{mp-1}$$

for $0 \leq x \leq 1$ and 0 otherwise.

The proof of this lemma is simple; hence it is omitted. The density function (3.1) will be denoted by $B(p, mp)$.

TABLE 1
MVUE's of reliability function

Life distribution	$\hat{\theta}$	V	Density function of V	$R^*(t, \hat{\theta})$
<i>Normal:</i> $N(\theta, 1)$ $(2\pi)^{-1/2} \exp[-(x - \theta)^2/2]$	\bar{X}	$Z - \bar{X}$	$N(0, (n - 1)/n)$	$G[(n/(n - 1))^\dagger(t - \bar{X})]$
<i>Normal:</i> $N(\theta_1, \theta_2)$ $(2\pi\theta_2)^{-1/2} \exp[-(x - \theta_1)^2/2\theta_2]$	(\bar{X}, s^2)	$(Z - \bar{X})/s$	$[1 - x^2/(n - 1)]^{(n-1)/2} / [(n - 1)^\dagger \theta_2^{1/2} (n - 2)/2]$ for $ x < (n - 1)^\dagger$	$\begin{cases} \frac{1}{2}[1 + I_{\tau^2}(\frac{1}{2}, (n - 2)/2)] & \text{if } \tau \leq 0 \\ \frac{1}{2}[1 - I_{\tau^2}(\frac{1}{2}, (n - 2)/2)] & \text{if } \tau \geq 0 \end{cases}$
			See Cramér [3] Sec. 29.4	where $\tau = (t - \bar{X})/s(n - 1)^\dagger$
<i>Gamma:</i> $\theta^{-p}\Gamma^{-1}(p)e^{-x/\theta}x^{p-1}$ p known	S_1	Z/S_1	$B(p, (n - 1)p)$	$1 - I_{t/S_1}(p, (n - 1)p)$
<i>Exponential:</i> $(1/\theta)e^{-x/\theta}$	S_1	Z/S_1	$B(1, (n - 1))$	$(1 - t/S_1)^{n-1} \cdot \delta(S_1 - t)$
<i>Weibull:</i> $(p/\theta)x^{p-1} \exp[-x^p/\theta]$ p known	S_p	Z^p/S_p	$B(1, n - 1)$	$(1 - t^p/S_p)^{n-1} \cdot \delta(S_p - t^p)$

In all the above examples, $\lambda = 1$ and $Z = X_1$ are used in $U(\mathbf{X})$.

$$\bar{X} = \sum_{i=1}^n X_i/n, \quad s^2 = \sum_{i=1}^n (X_i - \bar{X})^2/n, \quad S_p = \sum_{i=1}^n X_i^p.$$

$$G(w) = (2\pi)^{-1/2} \int_w^\infty \exp[-x^2/2] dx. \quad \text{For } a, b > 0, I_w(a, b) = \begin{cases} \beta^{-1}(a, b) \int_0^w x^{a-1}(1-x)^{b-1} dx & \text{if } w < 0 \\ \beta^{-1}(a, b) & \text{if } 0 \leq w \leq 1 \\ 1 & \text{if } w > 1 \end{cases}$$

TABLE 2

MVUE's of k th power ($k \leq n$) of reliability function associated with two parameter exponential distribution using a censored sample

Case	$\hat{\theta}$	$\psi(t, \theta)$	λ	Z	V	Density function of V	$\psi^*(t, \hat{\theta})$
θ_1 known	S'	$R^k(t, \theta_2)$	1	$(Y_1 - (n - k)\theta_1)/k$	$\frac{k(Z - \theta_1)}{S' - n\theta_1}$	$B(1, r - 1)$	$\begin{cases} 1 - k(t - \theta_1)/(S' - n\theta_1)]^{r-1}, & t < \theta_1 \\ \theta_1 \leq t \leq [S' - (n - k)\theta_1]/k, & \\ 0, & t > [S' - (n - k)\theta_1]/k \end{cases}$
θ_2 known	$X_{(r)}$	$R^k(t, \theta_1)$ $-(k/n)R^n(t, \theta_1)$	$1 - k/n$	$(Y_2/k) + (Y_1/n)$	$k(Z - X_{(r)})$	$(1/\theta_2)e^{-x/\theta_2}$	$\begin{cases} 1 - k/n, & t \leq X_{(r)} \\ (1 - k/n) \exp[-k(t - X_{(r)})/\theta_2], & \\ 0, & t \geq X_{(r)} \end{cases}$
		$(k/n)R^n(t, \theta_1)$	k/n	Y_1/n			$\begin{cases} k/n, & t \leq X_{(r)} \\ 0, & t > X_{(r)} \end{cases}$
		$*R^k(t, \theta_1)$					$\begin{cases} 1, & t \leq X_{(r)} \\ (1 - k/n) \exp[-k(t - X_{(r)})/\theta_2], & \\ 0, & t > X_{(r)} \end{cases}$
θ_1, θ_2 unknown	$(X_{(r)}, S')$	$R^k(t, \theta)$ $-(k/n)R^n(t, \theta)$	$1 - k/n$	$(Y_2/k) + (Y_1/n)$	$\frac{k(Z - X_{(r)})}{S' - nX_{(r)}}$	$B(1, r - 2)$	$\begin{cases} 1 - k/n, & t < X_{(r)} \\ (1 - k/n)[1 - k(t - X_{(r)})/(S' - nX_{(r)})]^{r-2}, & \\ X_{(r)} \leq t \leq [S' - (n - k)X_{(r)}]/k, & \\ 0, & t > [S' - (n - k)X_{(r)}]/k \end{cases}$
		$(k/n)R^n(t, \theta)$	k/n	Y_1/n			$\begin{cases} k/n, & t \leq X_{(r)} \\ 0, & t > X_{(r)} \end{cases}$
		$*R^k(t, \theta)$					$\begin{cases} 1, & t < X_{(r)} \\ (1 - k/n)[1 - k(t - X_{(r)})/(S' - nX_{(r)})]^{r-2}, & \\ X_{(r)} \leq t \leq [S' - (n - k)X_{(r)}]/k, & \\ 0, & t > [S' - (n - k)X_{(r)}]/k \end{cases}$

* By addition.

† The unbiased estimate $U(X)$, being a function of the sufficient statistic, is itself the MVUE.

$$S' = \sum_{i=1}^r X_{(i)} + (n - r)X_{(r)}$$

The steps in the derivation of the MVUE's of reliability function associated with the normal, gamma, one-parameter exponential and Weibull distributions are given in Table 1. Similar steps for obtaining the MVUE's of powers of reliability function, associated with the two-parameter exponential distribution

$$f(x) = (1/\theta_2) \exp [-(x - \theta_1)/\theta_2] \delta(x - \theta_1), \quad \theta_1 \geq 0, \theta_2 > 0,$$

where

$$\begin{aligned} \delta(w) &= 1 && \text{if } w \geq 0 \\ &= 0 && \text{otherwise} \end{aligned}$$

using only r ($r \leq n$) smallest observations (censored sample) are shown in Table 2. In order to apply Theorem 1 effectively to this distribution, the following transformation (Epstein and Sobel [4]) from X 's to Y 's is made:

$$Y_i = (n - i + 1)(X_{(i)} - X_{(i-1)}), \quad X_{(0)} = 0, \quad i = 1, 2, \dots, r.$$

Here $X_{(i)}$ is the i th smallest observation. The Y 's are then mutually independent. The density function of Y_1 is

$$f(x) = (1/\theta_2) \exp [-(x - n\theta_1)/\theta_2], \quad x \geq n\theta_1,$$

and that of Y_i , ($i = 2, 3, \dots, r$), is

$$f(x) = (1/\theta_2) \exp [-x/\theta_2], \quad x \geq 0.$$

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